

**N-Channel MOSFET** 

### **General Description**

The WSL60N65 is CoolFET II MOSFET family that is utilizing charge balance technology for extremely low on-resistance and low gate charge performance.

WSL60N65 is suitable for applications which require superior power density and outstanding efficiency

#### **Features**

- High ruggedness
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability

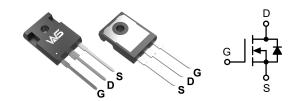
### **Product Summery**

BV <sub>DSS</sub>	R <sub>DS(ON)</sub>	I <sub>D</sub>
650V	150mΩ	60A

### **Applications**

- Uninterruptible Power Supply(UPS)
- Power Factor Correction (PFC)

### **TO-247-3L Pin Configuration**



## **Absolute Maximum Ratings** (T<sub>C</sub>=25°C, Unless Otherwise Noted)

Symbol	Parameter	Rating	Units	
$V_{DS}$	Drain-Source Voltage	650	V	
$V_{GS}$	Gate-Source Voltage	±30	V	
I <sub>D</sub>	Continuous Drain Current	60	А	
I <sub>DM</sub>	Pulsed Drain Current <sup>1</sup>	142	А	
E <sub>AS</sub>	Single Pulse Avalanche Energy <sup>2</sup>	500	mJ	
$P_{D}$	Power Dissipation (T <sub>C</sub> =25°C)	151	W	
T <sub>STG</sub>	Storage Temperature Range	-55 to 150	°C	
$T_J$	Operating Junction Temperature Range	-55 to 150	°C	

#### **Thermal Data**

Symbol	Parameter	Тур.	Max.	Units	
$R_{ heta JA}$	Thermal Resistance, Junction-to-Ambient		62	°C/W	
$R_{ heta JC}$	Thermal Resistance, Junction-to-Case		0.82	°C/W	



## **Electrical Characteristics** (T<sub>J</sub>=25°C, Unless Otherwise Noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Units	
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V , I <sub>D</sub> =250μA	650			V	
$\Delta BV_{DSS}/\Delta T_{J}$	BV <sub>DSS</sub> Temperature Coefficient	I <sub>D</sub> =250μA,Reference 25°C		0.7		V/°C	
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> =10V , I <sub>D</sub> =3.2A		150	190	mΩ	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS}=V_{DS}$ , $I_D=250\mu A$	2.5	3.3	4.5	V	
	Drain-Source Leakage Current	V <sub>DS</sub> =650V , V <sub>GS</sub> =0V			1.0	μΑ	
I <sub>DSS</sub>		V <sub>DS</sub> =520V , T <sub>C</sub> =125°C			50		
I <sub>GSS</sub>	Gate-Source Leakage Current	V <sub>DS</sub> =0V , V <sub>GS</sub> =±30V			±100	nA	
$Q_g$	Total Gate Charge	\\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \		7.27			
$Q_{gs}$	Gate-Source Charge	V <sub>DS</sub> =480V , V <sub>GS</sub> =10V , I <sub>D</sub> =11A		17.4		· nC	
$Q_{gd}$	Gate-Drain Charge	- ID-TTA		43.9			
T <sub>d(on)</sub>	Turn-On Delay Time			10			
T <sub>r</sub>	Rise Time	V <sub>DS</sub> =400V , I <sub>D</sub> =13A		19.8			
T <sub>d(off)</sub>	Turn-Off Delay Time	$R_G$ =4.7 $\Omega$ , $V_{GS}$ =13 $V$		45.4		ns	
$T_f$	Fall Time			41.4			
C <sub>iss</sub>	Input Capacitance			1510			
C <sub>oss</sub>	Output Capacitance	$V_{DS}$ =100V, $V_{GS}$ =0V, f = 1.0MHz		65	pF		
C <sub>rss</sub>	Reverse Transfer Capacitance			2.4			

#### **Diode Characteristics**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Units
I <sub>S</sub>	Continuous Source Current	V <sub>D</sub> =V <sub>G</sub> =0V, Force Current			60	Α
I <sub>SM</sub>	Pulsed Source Current	v <sub>D</sub> =v <sub>G</sub> =uv, Force Current			180	Α
$V_{SD}$	Diode Forward Voltage	V <sub>GS</sub> =0V , I <sub>S</sub> =7.3A		0.812	1.5	V
t <sub>rr</sub>	Reverse Recovery Time	V <sub>GS</sub> =0V , I <sub>S</sub> =11A , V <sub>DD</sub> =400V		288		ns
Q <sub>rr</sub>	Reverse Recovery Charge	di <sub>F</sub> /dt=100A/µs		3.66		μC

#### Note:

- 1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- 2. The E\_{AS} data shows Max. rating . L=0.5mH,  $\,I_{AS}\!=\!7A,\,\,V_{DD}\!=\!50V,\,\,R_{G}\!=\!25\Omega$
- 3. The test condition is Pulse Test:  $I_{SD} \le I_{D}$ ,  $di/dt = 100 A/\mu s$ ,  $V_{DD} \le BV_{DSS}$ , Starting at  $T_{J}$ =25°C
- 4. The power dissipation is limited by 150  $^{\circ}\text{C}$  junction temperature
- 5. The data is theoretically the same as  $\ensuremath{I_D}$  and  $\ensuremath{I_{DM}}$  , in real applications , should be limited by total power dissipation.



## **Typical Characteristics**

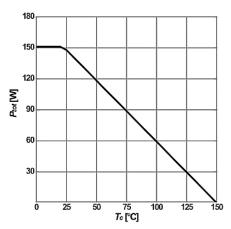


Figure1: Power dissipation (Non FullPAK)

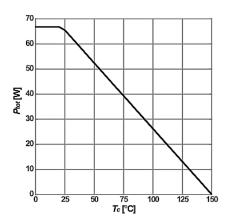


Figure3: Power dissipation  $P_{\text{tot}}=f(T_{\text{C}})$ 

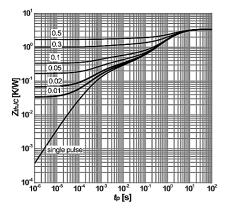


Figure 5: Max. transient thermal impedance  $Z_{thJC}$ =f( $t_p$ ); parameter: D=  $t_p$ /T

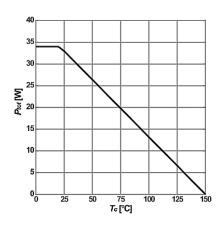


Figure2: Power dissipation (FullPAK)

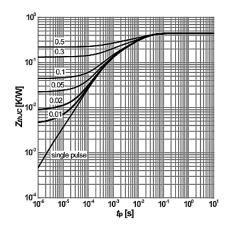


Figure4:Max. transient thermal impedance  $Z_{thJC}$ =f( $t_p$ ); parameter: D=  $t_p$ /T

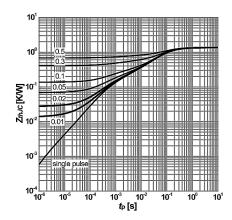


Figure6: Max. transient thermal impedance  $Z_{thJC}$ =f( $t_p$ ); parameter: D=  $t_p/T$ 



## **Typical Characteristics (Cont.)**

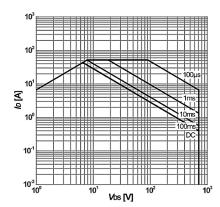


Figure 7: Safe operating area (Non FullPAK)  $I_D=f(V_{DS}); T_J=25^{\circ}C; D=0; parameter: t_p$ 

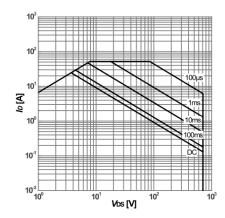


Figure9 : TSafe operating area (FullPAK-TO220A)

Ros(on)=f(ID); Tj=25°C; parameter: Vos

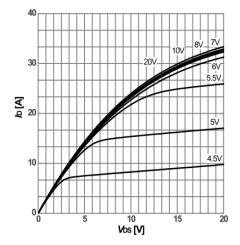


Figure 11: Typ. output characteristics

 $I_D=f(V_{DS})$ ;  $T_j=125$ °C; parameter:  $V_{GS}$ 

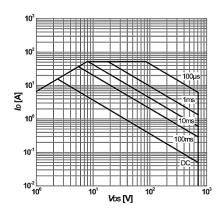


Figure8 : Safe operating area (Non FullPAK)

 $I_D=f(V_{DS})$ ;  $T_j=25^{\circ}C$ ; D=0; parameter:  $t_D$ 

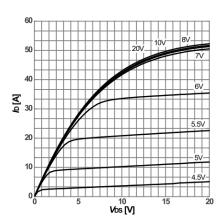


Figure 10: Typ. output characteristics  $R_{DS}(on)=f(T_i); I_D=3.2A; V_{GS}=10V$ 

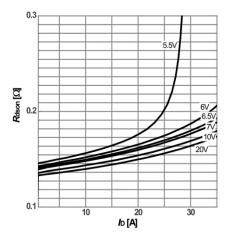
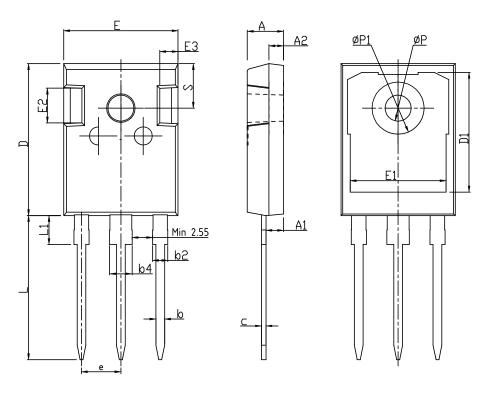


Figure 12: Type. gate charge R<sub>DS</sub>(on)=f(I<sub>D</sub>); T<sub>J</sub>=25°C; parameter: V<sub>GS</sub>





# **Packaging information**



Comple al	Millimeters					
Symbol	Min.	Nom.	Max.			
Α	4.80	5.00	5.20			
A1	2.21	2.41	2.61			
A2	1.85	2.00	2.15			
b	1.11	1.21	1.36			
b2	1.91	2.01	2.21			
b4	2.91	3.01	3.21			
С	0.51	0.61	0.75			
D	20.70	21.00	21.30			
D1	16.25	16.55	16.85			
E	15.50	15.80	16.10			
E1	13.00	13.30	13.60			
E2	4.80	5.00	5.20			
E3	2.30	2.50	2.70			
е		5.44 BSC				
L	19.62	19.92	20.22			
L1	-	-	4.30			
Р	3.40	3.60	3.80			
P1	-	-	7.30			
S	6.15 BSC					



### **Attention**

- 1, Any and all Winsok power products described or contained herein do not have specifications that can handle applications that require extremely high levels of reliability, such as life–support systems, aircraft's control systems, or other applications whose failure can be reasonably expected to result in serious physical and/or material damage. Consult with your Winsok power representative nearest you before using any Winsok power products described or contained herein in such applications.
- 2, Winsok power assumes no responsibility for equipment failures that result from using products at values that exceed, even momentarily, rated values (such as maximum ratings, operating condition ranges, or other parameters) listed in products specifications of any and all Winsok power products described or contained herein.
- 3, Specifications of any and all Winsok power products described or contained herein stipulate the performance, characteristics, and functions of the described products in the independent state, and are not guarantees of the performance, characteristics, and functions of the described products as mounted in the customer's products or equipment. To verify symptoms and states that cannot be evaluated in an independent device, the customer should always evaluate and test devices mounted in the customer's products or equipment.
- 4, Winsok power Semiconductor CO., LTD. strives to supply high–quality high–reliability products. However, any and all semiconductor products fail with some probability. It is possible that these probabilistic failures could give rise to accidents or events that could endanger human lives that could give rise to smoke or fire, or that could cause damage to other property. When designing equipment, adopt safety measures so that these kinds of accidents or events cannot occur. Such measures include but are not limited to protective circuits and error prevention circuits for safe design, redundant design, and structural design.
- 5, In the event that any or all Winsok power products (including technical data, services) described or contained herein are controlled under any of applicable local export control laws and regulations, such products must not be exported without obtaining the export license from the authorities concerned in accordance with the above law.
- 6, No part of this publication may be reproduced or transmitted in any form or by any means, electronic or mechanical, including photocopying and recording, or any information storage or retrieval system, or otherwise, without the prior written permission of Winsok power Semiconductor CO., LTD.
- 7, Information (including circuit diagrams and circuit parameters) herein is for example only; it is not guaranteed for volume production. Winsok power believes information herein is accurate and reliable, but no guarantees are made or implied regarding its use or any infringements of intellectual property rights or other rights of third parties.
- 8, Any and all information described or contained herein are subject to change without notice due to product/technology improvement, etc. When designing equipment, refer to the "Delivery Specification" for the Winsok power product that you Intend to use.
- 9, this catalog provides information as of Sep.2014. Specifications and information herein are subject to change without notice.